## Ghousia College of Engineering Department of Electronics and Communication

## EC 56: Solid State Devices and Technology

Internal Exam-Solutions #1

## Problem I.

- 1. For a germanium sample, at 300°K has a concentration of free electrons as  $5.8 \times 10^{18} / cm^3$ , and holes as  $10.58 \times 10^{19} / cm^3$ , with applied electric field of 2 V/cm. Take  $n_i = 2.5 \times 10^{13} / cm^3$  at  $300^{\circ}K$ ,  $\mu_n = 3,800 \ cm^2/V$ -s,  $\mu_p = 1,800 \ cm^2/V$ -s,  $D_n = 99 \ cm^2/s$ ,  $D_p = 47 \ cm^2/s$ .
  - (a) Find the drift current due to electrons and holes. (4 Marks) **A:**  $J_n = qn\mu_n\varepsilon = 1.6 \times 10^{-19} \times 5.8 \times 10^{18} \times 3800 \times 2 = 7052.8 \ A/cm^2$  $J_p = qp\mu_p\varepsilon = 1.6 \times 10^{-19} \times 10.58 \times 10^{19} \times 1800 \times 2 = 60940.8 \ A/cm^2$
  - (b) If there exists a gradient of concentration of holes and electrons with |dp/dx| = 2 × 10<sup>18</sup> /cm<sup>4</sup> and |dn/dx| = 5 × 10<sup>17</sup> /cm<sup>4</sup> respectively, then find diffusion current densities due to holes and electrons. (4 Marks)
    A: J<sub>p</sub> = -qD<sub>p</sub>dp/dx = -1.6 × 10<sup>-19</sup> × 47 × 2 × 10<sup>18</sup> = -15.04 A/cm<sup>2</sup> J<sub>n</sub> = qD<sub>n</sub>dn/dx = 1.6 × 10<sup>-19</sup> × 99 × 5 × 10<sup>17</sup> = 7.92 A/cm<sup>2</sup>
  - (c) Using the results obtained in (a) and (b) find the total current densities due to holes and electrons. (2 Marks) A: Total current density due to electrons =  $qn\mu_n\varepsilon + qD_ndn/dx = 7052.8 + 7.92 = 7060.72$  $A/cm^2$

Total current density due to holes =  $qp\mu_p\varepsilon - qD_pdp/dx = 60940.8 - 15.04 = 60925.76 \ A/cm^2$ 

2. An abrupt (or step-graded) p-n junction is formed with  $N_A = 10^{16} / cm^3$  and  $N_D = 4 \times 10^{18} / cm^3$  of circular cross-section, with diameter of 0.02 cm. Calculate the following, (i)  $V_0 = \text{Contact}$  potential at open-circuited junction, (ii) depletion width W (iii)  $x_{p_0} =$  depletion width on the p-side (iv)  $Q^+ =$  total positive charge in the depletion region (v)  $\varepsilon_0 =$  Electric field present at the junction. (vi) Draw the graph for  $\rho_v =$  volume charge density. (vii) Draw the graph for electric field intensity  $\varepsilon$ . (viii)  $x_{n_0} =$  depletion width on the n-side. Take  $n_i = 1.5 \times 10^{10} / cm^3$ , and  $\epsilon_r = 11.8$ . (2+2+2+2+2+2+1 Marks)

 $\mathbf{A:} (i) \ V_0 = V_T \ ln \frac{N_A N_D}{n_i^2} = 26 \times 10^{-3} \ ln \frac{10^{16} \times 4 \times 10^{18}}{(1.5 \times 10^{10})^2} = 0.85 \ V \ (ii) \ W = \left(\frac{2\epsilon_r \epsilon_0 V_0}{q} \left(\frac{1}{N_A} + \frac{1}{N_D}\right)\right)^{\frac{1}{2}} = 3.34 \times 10^{-5} \ cm. \ (iii) \ x_{p_0} = \frac{N_D W}{N_A + N_D} = 3.331 \times 10^{-5} \ cm. \ (iv) \ Q^+ = q x_{p_0} N_A \times \pi (0.02/2)^2 = 6.655 \times 10^{-9} \ C \ (v) \ \varepsilon_0 = -\frac{q N_A x_{p_0}}{\epsilon_r \epsilon_0} = -5.06 \times 10^4 \ V/cm. \ (vi) \ and. \ (vii) \ graphs are shown in the Fig.1(a) \ and. \ (b). \ (viii) \ x_{n_0} = W - x_{p_0} = 3 \times 10^{-8} \ cm = 3^o A$ 

## Problem II.

- (a) Define different modes of operation for BJT. (3 Marks)
   A: Refer to the lecture notes-6, (LN-6) table-1.
  - (b) For an npn transistor operated with collector base junction reverse-biased by at least few volts, with emitter open circuited. Determine the following, (i) Mode of operation, (ii) V<sub>EB</sub>, (iii) collector and base currents, take I<sub>C0</sub> = 10<sup>-15</sup> A, I<sub>E0</sub> = 2 × 10<sup>-15</sup> A, α<sub>F</sub> = 0.99. (*Hint:* Use reciprocity condition) (iv) Find β<sub>F</sub>. (4+4+3+1 Marks).
    A: Refer to the LN-6 example problem. (iv) β<sub>F</sub> = α<sub>F</sub>/(1-α<sub>F</sub>) = 49.74
- 2. (a) Write Continuity equation for holes. (1.5 Marks)A: Refer to LN-2, Eqn.(33)

- (b) Define Reverse saturation current  $(I_0)$ . (1.5 Marks) A: Refer to LN-4, Eqn.(17)
- (c) Draw Ebers-Moll equivalent of npn transistor and write the equations for I<sub>E</sub> and I<sub>C</sub> in terms of V<sub>BE</sub> and V<sub>CE</sub>. (3 Marks)
  A: Refer to LN-5, Fig.9, Eqns.(14) and (15)
- (d) Draw the equivalent DC model for the npn BJT with CE configuration, operating in the forward-active region. (1 Mark)
  A: Refer to LN-7, Fig.5(a)
- (e) Draw the *I-V* characteristics of the *p-n* junction and explain each region (forward and reverse bias) in the graph using diode equation. (3 Marks)
  A: Refer to LN-4, The Volt-Ampere Characteristics of Diode.



Figure 1: (a) Charge Density  $\rho_v$  (b) Electric Field Intensity  $(\varepsilon)$